

MBN800E33D

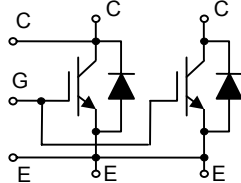
PRELIMINARY SPEC.

Silicon N-channel IGBT

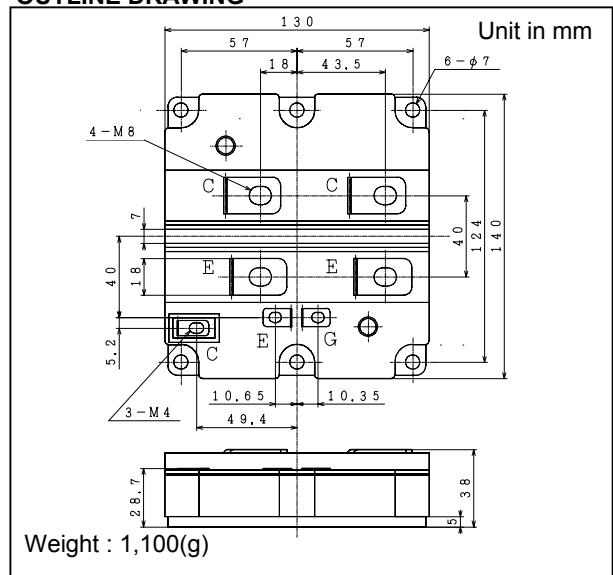
FEATURES

- * High speed, low loss IGBT module.
- * Low driving power due to low input capacitance MOS gate.
- * Low noise due to ultra soft fast recovery diode.
- * High reliability, high durability module.
- * High thermal fatigue durability.
($\Delta T_c=70^\circ\text{C}$, $N>30,000$ cycles)
- * Isolated heat sink (terminal to base).

CIRCUIT DIAGRAM



OUTLINE DRAWING



ABSOLUTE MAXIMUM RATINGS ($T_c=25^\circ\text{C}$)

Item	Symbol	Unit	MBN800E33D
Collector Emitter Voltage	V_{CES}	V	3,300
Gate Emitter Voltage	V_{GES}	V	± 20
Collector Current	DC	I_C	800
	1ms	I_{CP}	1,600
Forward Current	DC	I_F	800
	1ms	I_{FM}	1,600
Junction Temperature	T_j	$^\circ\text{C}$	-40 ~ +125
Storage Temperature	T_{stg}	$^\circ\text{C}$	-40 ~ +125
Isolation Voltage	V_{ISO}	V_{RMS}	6,000(AC 1 minute)
Screw Torque	Terminals (M4/M8)	-	2/10 (1)
	Mounting (M6)	-	6 (2)

Notes: (1) Recommended Value $1.8\pm 0.2/9\pm 1\text{N}\cdot\text{m}$ (2) Recommended Value $5.5\pm 0.5\text{N}\cdot\text{m}$

ELECTRICAL CHARACTERISTICS

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions	
Collector Emitter Cut-Off Current	I_{CES}	mA	-	-	12.0	$V_{CE}=3,300\text{V}$, $V_{GE}=0\text{V}$, $T_j=25^\circ\text{C}$	
			-	14	40	$V_{CE}=3,300\text{V}$, $V_{GE}=0\text{V}$, $T_j=125^\circ\text{C}$	
Gate Emitter Leakage Current	I_{GES}	nA	-500	-	+500	$V_{GE}=\pm 20\text{V}$, $V_{CE}=0\text{V}$, $T_j=25^\circ\text{C}$	
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	V	-	4.2	5.0	$I_C=800\text{A}$, $V_{GE}=15\text{V}$, $T_j=125^\circ\text{C}$	
Gate Emitter Threshold Voltage	$V_{GE(TH)}$	V	4.5	6.0	7.0	$V_{CE}=10\text{V}$, $I_C=800\text{mA}$, $T_j=25^\circ\text{C}$	
Input Capacitance	C_{ies}	nF	-	75	-	$V_{CE}=10\text{V}$, $V_{GE}=0\text{V}$, $f=100\text{kHz}$, $T_j=25^\circ\text{C}$	
Internal Gate Resistance	$R_{g(int)}$	Ω	-	1.8	-	$V_{CE}=10\text{V}$, $V_{GE}=0\text{V}$, $f=100\text{kHz}$, $T_j=25^\circ\text{C}$	
Switching Times	Rise Time	t_r	-	1.9	3.1	$V_{CC}=1,650\text{V}$, $I_C=800\text{A}$	
	Turn On Time	t_{on}	-	2.4	3.3	$L=120\text{nH}$	
	Fall Time	t_f	-	1.0	2.5	$R_G=4.7\Omega$ (3)	
	Turn Off Time	t_{off}	-	3.0	5.1	$V_{GE}=\pm 15\text{V}$, $T_j=125^\circ\text{C}$	
Peak Forward Voltage Drop	V_{FM}	V	-	2.5	3.0	$I_C=800\text{A}$, $V_{GE}=0\text{V}$, $T_j=125^\circ\text{C}$	
Reverse Recovery Time	t_{rr}	μs	-	0.6	1.1	$V_{CC}=1,650\text{V}$, $I_C=800\text{A}$, $L=120\text{nH}$ $T_j=125^\circ\text{C}$	
Turn On Loss	$E_{on(10\%)}$	J/P	-	1.1	1.4	$V_{CC}=1,650\text{V}$, $I_C=800\text{A}$, $L=120\text{nH}$	
Turn Off Loss	$E_{off(10\%)}$	J/P	-	0.9	1.2	$R_G=4.7\Omega$ (3)	
Reverse Recovery Loss	$E_{rr(10\%)}$	J/P	-	0.8	1.3	$V_{GE}=\pm 15\text{V}$, $T_j=125^\circ\text{C}$	
Stray inductance module	L_{SCE}	nH	-	18	-		
Partial Discharge Extinction Voltage	V_{ex}	Vrms	2.5	-	-	50Hz, $Q<10\text{pC}$	
Thermal Impedance	IGBT	$R_{th(j-c)}$	$^\circ\text{C/W}$	-	-	0.013	Junction to case
	FWD	$R_{th(j-c)}$	$^\circ\text{C/W}$	-	-	0.026	
Contact Thermal Impedance	$R_{th(c-f)}$	$^\circ\text{C/W}$	-	0.008	-	Case to fin	

Notes:(3) R_G value is a test condition value for evaluation, not recommended value.Please, determine the suitable R_G value by measuring switching behaviors.

* Please contact our representatives at order.

* For improvement, specifications are subject to change without notice.

* For actual application, please confirm this spec sheet is the newest revision.